# FAIRCHILD

July 2010

SEMICONDUCTOR® FDMS3016DC

# N-Channel Dual Cool<sup>TM</sup> PowerTrench<sup>®</sup> MOSFET 30 V, 49 A, 6.0 m $\Omega$

#### Features

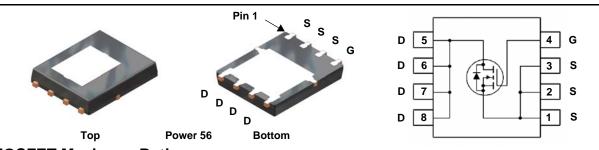
- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max  $r_{DS(on)} = 6.0 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 12 \text{ A}$
- Max  $r_{DS(on)}$  = 9.0 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 10 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- RoHS Compliant

### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process. Advancements in both silicon and Dual  $Cool^{TM}$  package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

#### Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation



MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

| Symbol                            | Parameter                                    |                        |           | Ratings     | Units |
|-----------------------------------|--|------------------------|-----------|-------------|-------|
| V <sub>DS</sub>                   | Drain to Source Voltage                      |                        |           | 30          | V     |
| V <sub>GS</sub>                   | Gate to Source Voltage                       |                        |           | ±20         | V     |
|                                   | Drain Current -Continuous (Package limited)  | T <sub>C</sub> = 25 °C |           | 49          |       |
|                                   | -Continuous (Silicon limited)                | T <sub>C</sub> = 25 °C |           | 78          | A     |
| D                                 | -Continuous                                  | T <sub>A</sub> = 25 °C | (Note 1a) | 18          | A     |
|                                   | -Pulsed                                      |                        |           | 200         |       |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy                |                        | (Note 3)  | 72          | mJ    |
| dv/dt                             | Peak Diode Recovery dv/dt                    |                        | (Note 4)  | 1.3         | V/ns  |
| D                                 | Power Dissipation                            | T <sub>C</sub> = 25 °C |           | 60          | W     |
| PD                                | Power Dissipation                            | T <sub>A</sub> = 25 °C | (Note 1a) | 3.3         | vv    |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature R | ange                   |           | -55 to +150 | °C    |

### **Thermal Characteristics**

| $R_{\thetaJC}$      | Thermal Resistance, Junction to Case    | (Top Source)   | 5.7 |      |
|---------------------|---|----------------|-----|------|
| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case    | (Bottom Drain) | 2.1 |      |
| $R_{	hetaJA}$       | Thermal Resistance, Junction to Ambient | (Note 1a)      | 38  |      |
| $R_{	hetaJA}$       | Thermal Resistance, Junction to Ambient | (Note 1b)      | 81  | °C/W |
| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1i)      | 16  |      |
| $R_{	hetaJA}$       | Thermal Resistance, Junction to Ambient | (Note 1j)      | 23  |      |
| $R_{	hetaJA}$       | Thermal Resistance, Junction to Ambient | (Note 1k)      | 11  |      |

#### Package Marking and Ordering Information

| Device Marking | Device     | Package                          | Reel Size | Tape Width | Quantity   |
|----------------|------------|----------------------------------|-----------|------------|------------|
| 3016           | FDMS3016DC | Dual Cool <sup>TM</sup> Power 56 | 13"       | 12 mm      | 3000 units |

| Symbol  | Parameter  | Test Conditions   | Min | Тур       | Max  | Units         |
|---|--|---|-----|-----------|------|---------------|
| Off Chara   | cteristics   |   |     |           |      |               |
| BV <sub>DSS</sub>   | Drain to Source Breakdown Voltage  | I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V                          | 30  |           |      | V             |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$                                | Breakdown Voltage Temperature<br>Coefficient   | $I_D = 250 \ \mu$ A, referenced to 25 °C                                |     | 17        |      | mV/°C         |
| I <sub>DSS</sub>  | Zero Gate Voltage Drain Current  | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$                           |     |           | 1    | μA            |
| I <sub>GSS</sub>  | Gate to Source Leakage Current   | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$                       |     |           | ±100 | nA            |
| On Chara  | cteristics   |   |     |           |      |               |
| V <sub>GS(th)</sub>   | Gate to Source Threshold Voltage   | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA             | 1.0 | 1.9       | 3.0  | V             |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$                            | Gate to Source Threshold Voltage<br>Temperature Coefficient                              | $I_D = 250 \ \mu\text{A}$ , referenced to 25 °C                         |     | -6        | 0.0  | mV/°C         |
| Δij   |  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A                           |     | 5.0       | 6.0  |               |
| r <sub>DS(on)</sub>   | Static Drain to Source On Resistance   | $V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$                            |     | 7.0       | 9.0  | mΩ            |
| 20(01)  |  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A, T <sub>J</sub> = 125 °C  |     | 7.5       | 9.4  | -             |
| 9 <sub>FS</sub>   | Forward Transconductance   | $V_{DS} = 5 \text{ V}, I_D = 12 \text{ A}$                              |     | 44        |      | S             |
| C <sub>oss</sub><br>C <sub>rss</sub><br>R <sub>g</sub><br>Switching | Output Capacitance<br>Reverse Transfer Capacitance<br>Gate Resistance<br>Characteristics | f = 1 MHz   |     | 87<br>0.9 | 135  | pF<br>pF<br>Ω |
| t <sub>d(on)</sub>  | Turn-On Delay Time   |   |     | 9         | 18   | ns            |
| t <sub>r</sub>  | Rise Time  | V <sub>DD</sub> = 15 V, I <sub>D</sub> = 12 A,                          |     | 3         | 10   | ns            |
| t <sub>d(off)</sub>   | Turn-Off Delay Time  | $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$                                 |     | 19        | 35   | ns            |
| t <sub>f</sub>  | Fall Time  |   |     | 2         | 10   | ns            |
| Qg  | Total Gate Charge  | $V_{GS} = 0 V$ to 10 V  |     | 16        | 23   | nC            |
| Qg  | Total Gate Charge  | $V_{GS} = 0 \text{ V to } 4.5 \text{ V} \text{ V}_{DD} = 15 \text{ V},$ |     | 7.6       | 10.6 | nC            |
| Q <sub>gs</sub>   | Gate to Source Gate Charge   | I <sub>D</sub> = 12 A   |     | 3         |      | nC            |
| Q <sub>gd</sub>   | Gate to Drain "Miller" Charge  |   |     | 2.5       |      | nC            |
| Drain-So  | arce Diode Characteristics   |   |     |           |      |               |
| V <sub>SD</sub>   | Source to Drain Diode Forward Voltage  | $V_{GS} = 0 V, I_S = 12 A$ (Note 2)                                     |     | 0.82      | 1.3  | V             |
|   |  | $V_{GS} = 0 V, I_S = 1.9 A$ (Note 2)                                    |     | 0.73      | 1.2  |               |
| t <sub>rr</sub>   | Reverse Recovery Time  | — I <sub>F</sub> = 12 A, di/dt = 100 A/μs                               |     | 25        | 45   | ns            |
| Q <sub>rr</sub>   | Reverse Recovery Charge  |   |     | 9         | 18   | nC            |

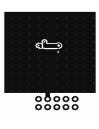
FDMS3016DC N-Channel Dual Cool<sup>TM</sup> PowerTrench<sup>®</sup> MOSFET

## **Thermal Characteristics**

| $R_{\theta JC}$  | Thermal Resistance, Junction to Case    | (Top Source)   | 5.7 |       |
|------------------|---|----------------|-----|-------|
| $R_{\theta JC}$  | Thermal Resistance, Junction to Case    | (Bottom Drain) | 2.1 |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1a)      | 38  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1b)      | 81  |       |
| R <sub>0JA</sub> | Thermal Resistance, Junction to Ambient | (Note 1c)      | 27  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1d)      | 34  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1e)      | 16  | 00 AM |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1f)      | 19  | °C/W  |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1g)      | 26  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1h)      | 61  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1i)      | 16  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1j)      | 23  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1k)      | 11  |       |
| $R_{\theta JA}$  | Thermal Resistance, Junction to Ambient | (Note 1I)      | 13  |       |

NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in  $^2\,\mathrm{pad}$  of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in  $^2$  pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

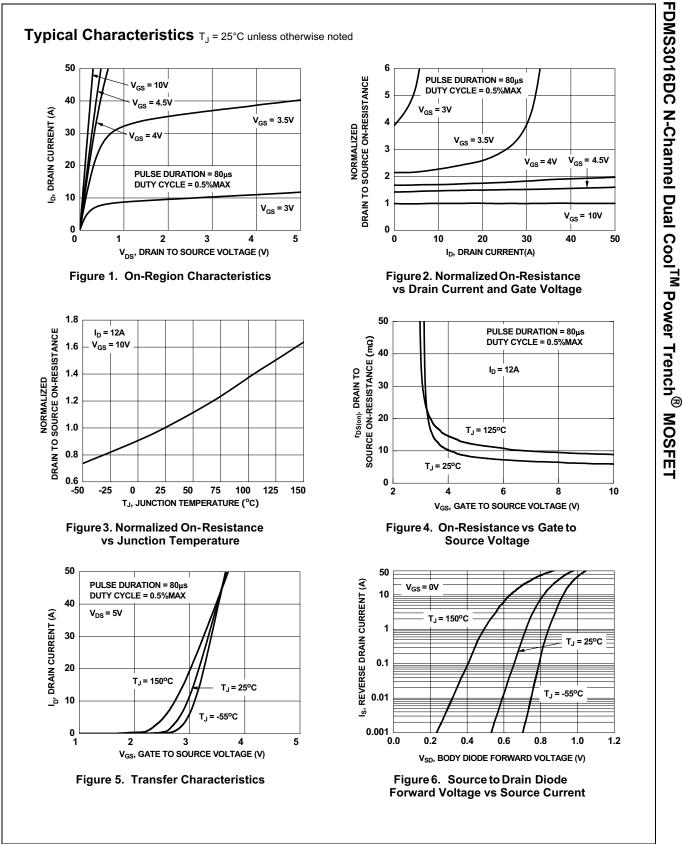
k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

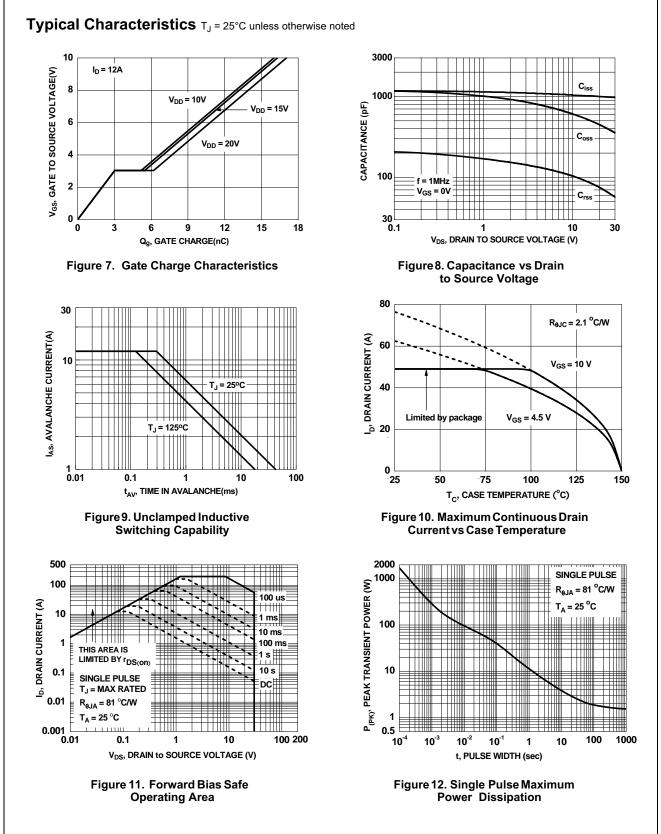
3.  $E_{AS}$  of 72 mJ is based on starting  $T_J$  = 25 °C, L = 1 mH,  $I_{AS}$  = 12 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V.

4.  $I_{SD} \leq$  12 A, di/dt  $\leq$  100 A/µs,  $V_{DD} \leq$  BV\_{DSS}, Starting  $T_J$  = 25 °C.



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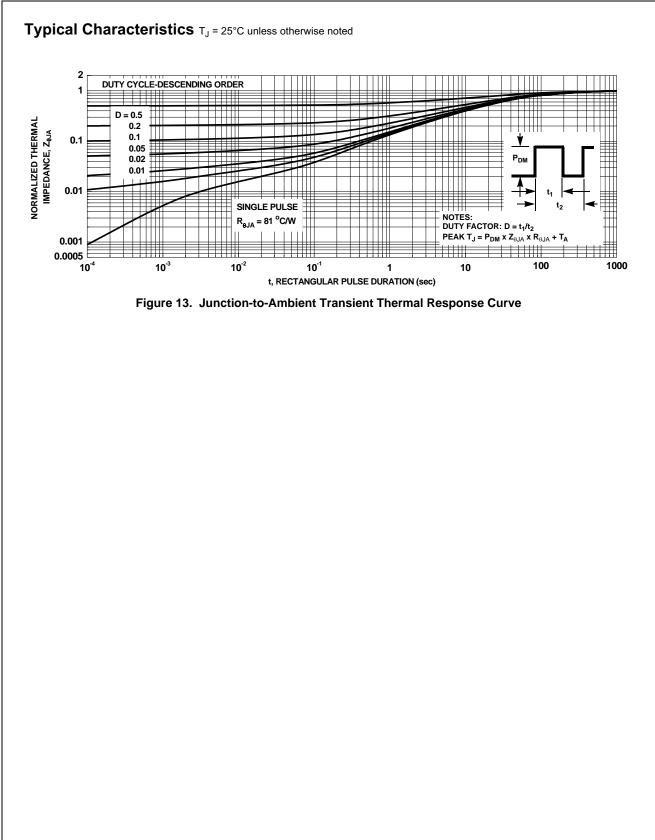
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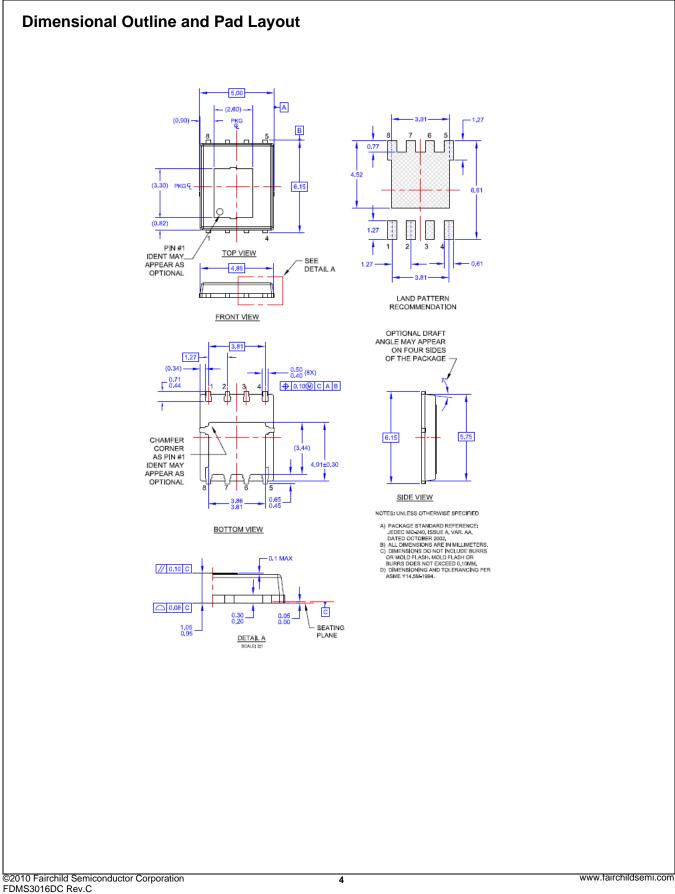
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5

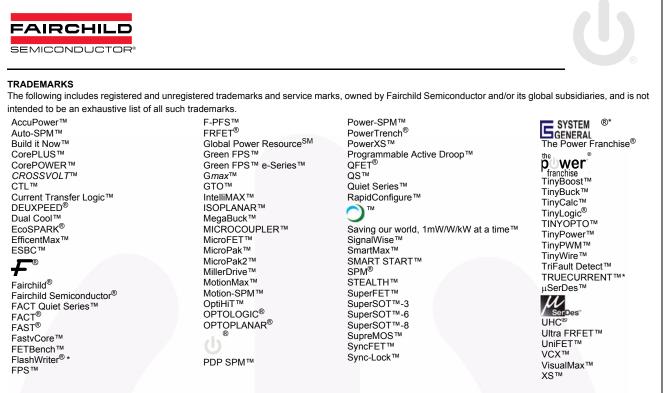


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6



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